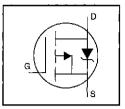
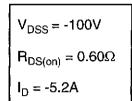
# International Rectifier

#### HEXFET® Power MOSFET

- Isolated Package
- High Voltage Isolation= 2.5KVRMS ®
- Sink to Lead Creepage Dist.= 4.8mm
- P-Channel
- 175°C Operating Temperature
- Dynamic dv/dt Rating
- Low Thermal Resistance

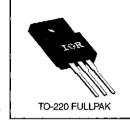




#### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.



#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
l <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10 V	-5.2	
ID @ Tc = 100°C	Continuous Drain Current, VGS @ -10 V	-3.6	_) A
l <sub>DM</sub>	Pulsed Drain Current ①	-21	_1
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Power Dissipation	37	W
	Linear Derating Factor	0.24	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	±20	V
Eas	Single Pulse Avalanche Energy ②	300	mJ
I <sub>AR</sub>	Avalanche Current ①	-5.2	Ā
EAR	Repetitive Avalanche Energy ①	3.7	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.5	V/ns
TJ	Operating Junction and	-55 to +175	
T <sub>STG</sub>	Storage Temperature Range		°Ç
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
· - · · · · · · · · · · · · · · · · · ·	Mounting Torque, 6-32 or M3 screw	10 lbf-in (1.1 N-m)	

#### Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
Rosc	Junction-to-Case	_		4.1	°C/W
ReJA	Junction-to-Ambient			65	

Document Number: 90199

www.vishay.com 665



## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	-100	_		· V	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA
ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	<b>-</b>	-0.10	_	V/°C	Reference to 25°C, ID=-1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	_		0.60	Ω	V <sub>GS</sub> =-10V, I <sub>D</sub> =-3.1A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0	_	-4.0	V	V <sub>DS</sub> =V <sub>GS</sub> , i <sub>D</sub> =-250μA
g <sub>is</sub>	Forward Transconductance	1.9	_	_	S	V <sub>DS</sub> =-50V, I <sub>D</sub> =-3.1A  €
IDSS	Drain-to-Source Leakage Current	_		-100		V <sub>DS</sub> =-100V, V <sub>GS</sub> =0V
1058	Diam-to-bodice Leakage Garrent	_	_	-500	μΑ	V <sub>DS</sub> =-80V, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C
IGSS	Gate-to-Source Forward Leakage	_	_	-100	nΑ	V <sub>GS</sub> =-20V
IGAS	Gate-to-Source Reverse Leakage	_	-	100	104	V <sub>GS</sub> =20V
$Q_g$	Total Gate Charge	-		18		I <sub>D</sub> =-6.8A
$\mathbf{Q}_{\mathrm{gs}}$	Gate-to-Source Charge	_		3.0	nC	V <sub>DS</sub> =-80V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		_	9.0		V <sub>GS</sub> =-10V See Fig. 6 and 13 ®
t <sub>d(on)</sub>	Turn-On Delay Time		9.6	_		V <sub>DD</sub> =-50V
tr	Rise Time	_	29	_	ns	I <sub>D</sub> =-6.8A
t <sub>d(off)</sub>	Turn-Off Delay Time	_	21		113	R <sub>G</sub> =18Ω
tr	Fall Time	_	25			R <sub>D</sub> =7.1Ω See Figure 10 ④
L <sub>D</sub>	Internal Drain Inductance	_	4.5	_	nH	Between lead, 6 mm (0.25in.)
Ls	Internal Source Inductance		7.5	_	HILL	from package and center of die contact
Ciss	Input Capacitance	_	390			V <sub>GS</sub> =0V
$C_{\sigma ss}$	Output Capacitance	-	170	_	pΕ	V <sub>DS</sub> =-25V
Crss	Reverse Transfer Capacitance	_	45	_		∫=1.0MHz See Figure 5
C	Drain to Sink Capacitance	_	12		pF	f=1.0MHz

### Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
ls	Continuous Source Current (Body Diode)			-5.2		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	_		-21	A	integral reverse p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage		-	-6.3	ν	T_=25°C, Is=-5.2A, VGS=0V @
t <sub>er</sub>	Reverse Recovery Time		100	200	ns	T_=25°C, I==-6.BA
Qrr	Reverse Recovery Charge	_	0.33	0.66	μC	di/dt=100A/μs ⊕
tor	Forward Turn-On Time	Intrinsic turn-on time is neglegible (turn-on is dominated by Ls+LD)				

#### Notes:

- Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ③ Isp≤-6.8A, di/dt≤110A/μs, V<sub>DD</sub>≤V(BR)DSS, T.i≤175°C
- ⑤ t=60s, f=60Hz

- ④ Pulse width ≤ 300 μs; duty cycle ≤2%.

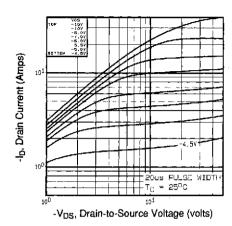


Fig 1. Typical Output Characteristics, Tc=25°C

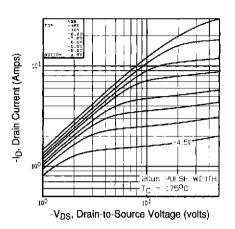


Fig 2. Typical Output Characteristics, T<sub>C</sub>=175°C

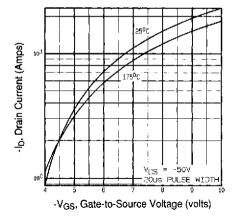


Fig 3. Typical Transfer Characteristics

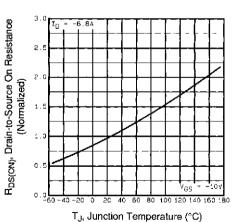


Fig 4. Normalized On-Resistance Vs. Temperature

Document Number: 90199

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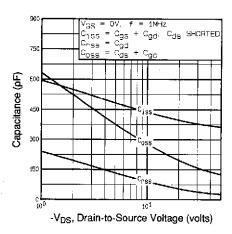


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

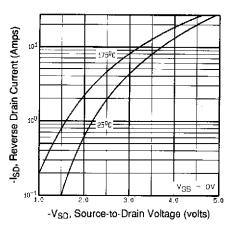


Fig 7. Typical Source-Drain Diode Forward Voltage

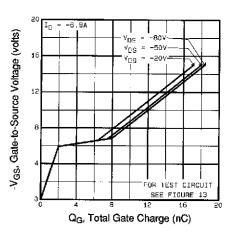


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

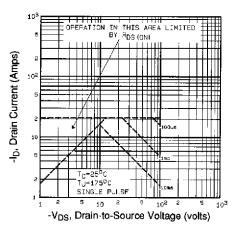


Fig 8. Maximum Safe Operating Area

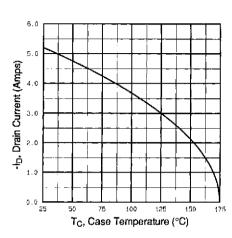


Fig 9. Maximum Drain Current Vs. Case Temperature

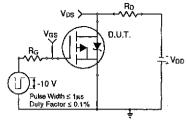


Fig 10a. Switching Time Test Circuit

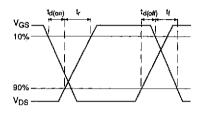


Fig 10b. Switching Time Waveforms

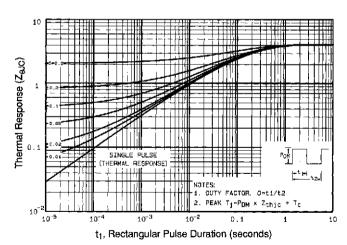


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



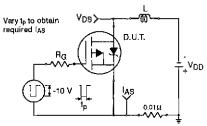


Fig 12a. Unclamped Inductive Test Circuit

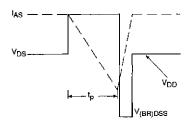


Fig 12b. Unclamped Inductive Waveforms

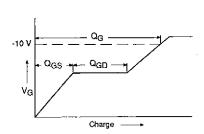


Fig 13a. Basic Gate Charge Waveform

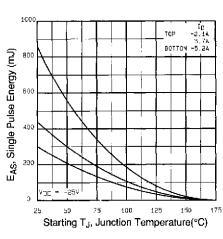


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

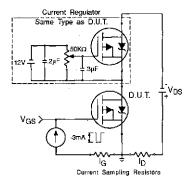


Fig 13b. Gate Charge Test Circuit

Appendix A: Figure 14, Peak Diode Recovery dv/dt Test Circuit - See page 1506

Appendix B: Package Outline Mechanical Drawing - See page 1510

Appendix C: Part Marking Information – See page 1517

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